

## OptiMOS™-T2 Power-Transistor



### Features

- N-channel Logic Level - Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

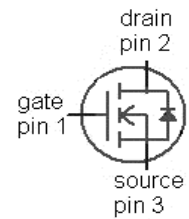
### Product Summary

|                  |     |    |
|------------------|-----|----|
| $V_{DS}$         | 40  | V  |
| $R_{DS(on),max}$ | 1.7 | mΩ |
| $I_D$            | 120 | A  |

PG-TO263-3-2



| Type            | Package     | Marking |
|-----------------|-------------|---------|
| IPB120N04S4L-02 | PG-TO263-3- | 4N04L02 |



Maximum ratings, at  $T_j=25\text{ °C}$ , unless otherwise specified

| Parameter                                    | Symbol         | Conditions                                      | Value        | Unit |
|----------------------------------------------|----------------|-------------------------------------------------|--------------|------|
| Continuous drain current <sup>1)</sup>       | $I_D$          | $T_C=25\text{ °C}$ , $V_{GS}=10\text{ V}$       | 120          | A    |
|                                              |                | $T_C=100\text{ °C}$ , $V_{GS}=10\text{ V}^{2)}$ | 120          |      |
| Pulsed drain current <sup>2)</sup>           | $I_{D,pulse}$  | $T_C=25\text{ °C}$                              | 480          |      |
| Avalanche energy, single pulse <sup>2)</sup> | $E_{AS}$       | $I_D=60\text{ A}$                               | 480          | mJ   |
| Avalanche current, single pulse              | $I_{AS}$       | -                                               | 120          | A    |
| Gate source voltage                          | $V_{GS}$       | -                                               | +20/-16      | V    |
| Power dissipation                            | $P_{tot}$      | $T_C=25\text{ °C}$                              | 158          | W    |
| Operating and storage temperature            | $T_j, T_{stg}$ | -                                               | -55 ... +175 | °C   |
| IEC climatic category; DIN IEC 68-1          | -              | -                                               | 55/175/56    |      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Thermal characteristics<sup>2)</sup>

|                                     |            |   |   |   |      |     |
|-------------------------------------|------------|---|---|---|------|-----|
| Thermal resistance, junction - case | $R_{thJC}$ | - | - | - | 0.95 | K/W |
|-------------------------------------|------------|---|---|---|------|-----|

### Electrical characteristics, at $T_j=25^\circ\text{C}$ , unless otherwise specified

#### Static characteristics

|                                  |               |                                                    |     |      |     |            |
|----------------------------------|---------------|----------------------------------------------------|-----|------|-----|------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0V, I_D=1mA$                               | 40  | -    | -   | V          |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}, I_D=110\mu A$                      | 1.2 | 1.7  | 2.2 |            |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=40V, V_{GS}=0V$                            | -   | 0.05 | 1   | $\mu A$    |
|                                  |               | $V_{DS}=18V, V_{GS}=0V, T_j=85^\circ\text{C}^{2)}$ | -   | 1    | 20  |            |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20V, V_{DS}=0V$                            | -   | -    | 100 | nA         |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=4.5V, I_D=50A$                             | -   | 1.9  | 2.3 | m $\Omega$ |
|                                  |               | $V_{GS}=10V, I_D=100A$                             | -   | 1.4  | 1.7 |            |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Dynamic characteristics<sup>2)</sup>

|                              |              |                                                        |   |       |       |    |
|------------------------------|--------------|--------------------------------------------------------|---|-------|-------|----|
| Input capacitance            | $C_{iss}$    | $V_{GS}=0V, V_{DS}=25V,$<br>$f=1MHz$                   | - | 11200 | 14560 | pF |
| Output capacitance           | $C_{oss}$    |                                                        | - | 1900  | 2470  |    |
| Reverse transfer capacitance | $C_{rss}$    |                                                        | - | 95    | 220   |    |
| Turn-on delay time           | $t_{d(on)}$  | $V_{DD}=20V, V_{GS}=10V,$<br>$I_D=120A, R_G=3.5\Omega$ | - | 16    | -     | ns |
| Rise time                    | $t_r$        |                                                        | - | 16    | -     |    |
| Turn-off delay time          | $t_{d(off)}$ |                                                        | - | 80    | -     |    |
| Fall time                    | $t_f$        |                                                        | - | 70    | -     |    |

### Gate Charge Characteristics<sup>2)</sup>

|                       |               |                                                       |   |     |     |    |
|-----------------------|---------------|-------------------------------------------------------|---|-----|-----|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=32V, I_D=120A,$<br>$V_{GS}=0 \text{ to } 10V$ | - | 32  | 42  | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                       | - | 16  | 37  |    |
| Gate charge total     | $Q_g$         |                                                       | - | 143 | 190 |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                       | - | 2.9 | -   | V  |

### Reverse Diode

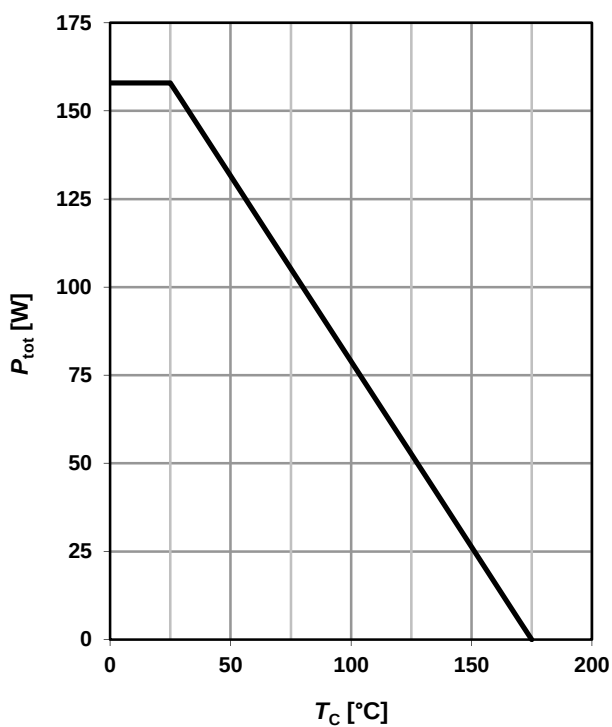
|                                                |               |                                             |   |     |     |    |
|------------------------------------------------|---------------|---------------------------------------------|---|-----|-----|----|
| Diode continuous forward current <sup>2)</sup> | $I_S$         | $T_C=25^\circ C$                            | - | -   | 120 | A  |
| Diode pulse current <sup>2)</sup>              | $I_{S,pulse}$ |                                             | - | -   | 480 |    |
| Diode forward voltage                          | $V_{SD}$      | $V_{GS}=0V, I_F=100A,$<br>$T_j=25^\circ C$  | - | 0.9 | 1.3 | V  |
| Reverse recovery time <sup>2)</sup>            | $t_{rr}$      | $V_R=20V, I_F=50A,$<br>$di_F/dt=100A/\mu s$ | - | 65  | -   | ns |
| Reverse recovery charge <sup>2)</sup>          | $Q_{rr}$      |                                             | - | 85  | -   | nC |

<sup>1)</sup> Current is limited by bondwire; with an  $R_{thJC} = 0.95K/W$  the chip is able to carry 290A at 25°C.

<sup>2)</sup> Defined by design. Not subject to production test.

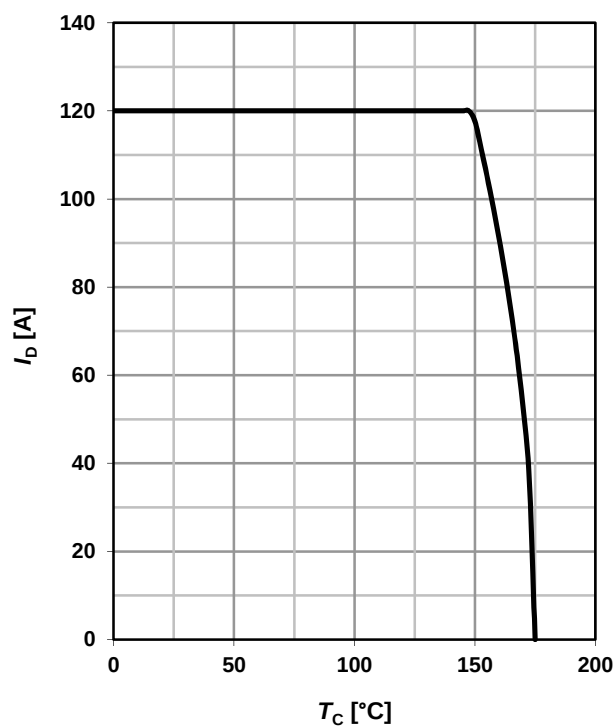
### 1 Power dissipation

$$P_{\text{tot}} = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



### 2 Drain current

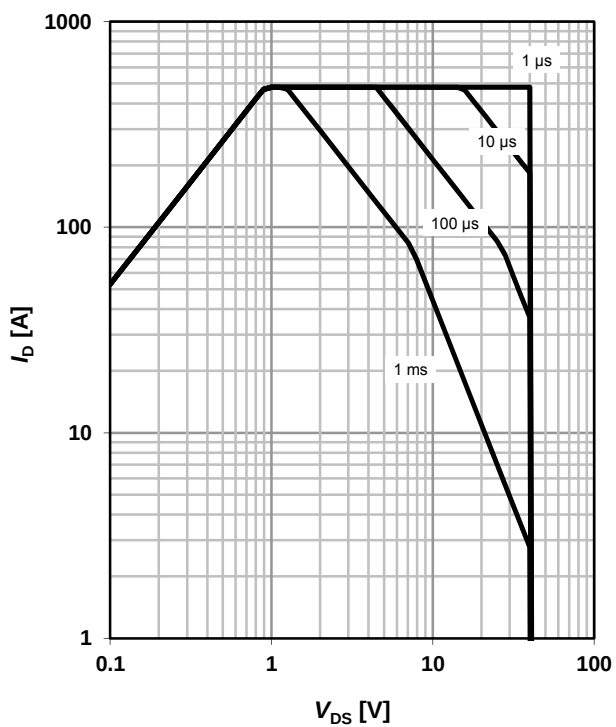
$$I_D = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



### 3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_C = 25^{\circ}\text{C}; D = 0$$

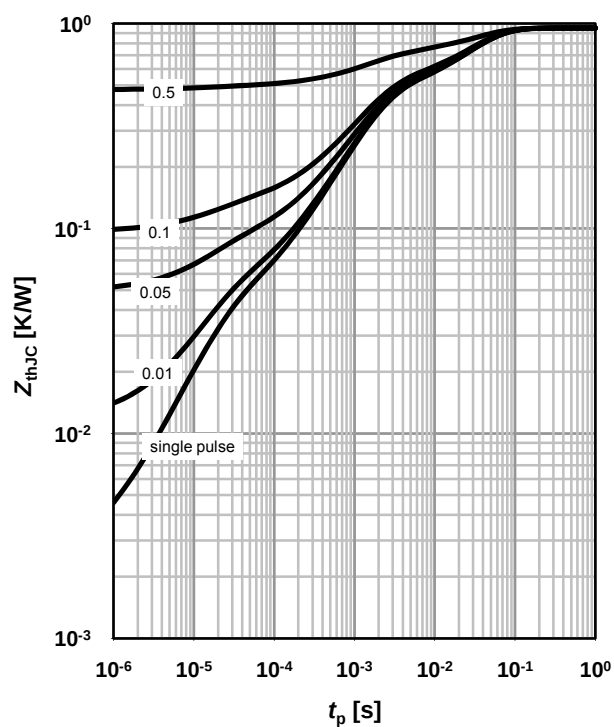
parameter:  $t_p$



### 4 Max. transient thermal impedance

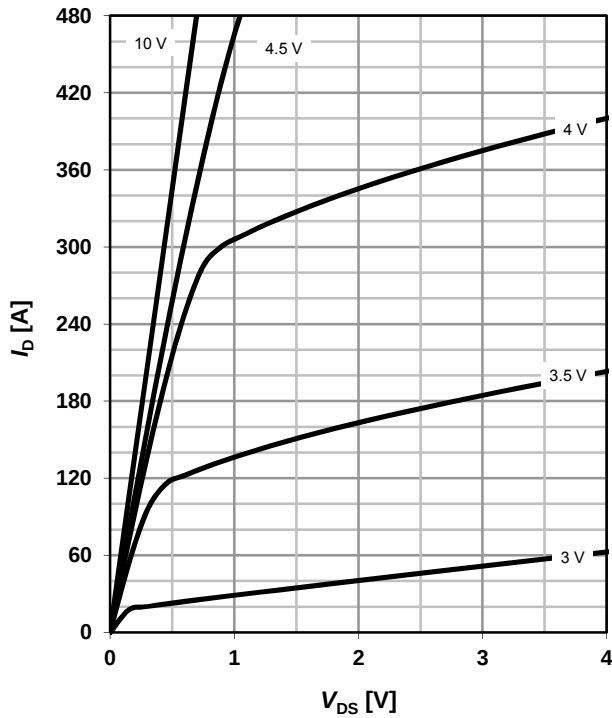
$$Z_{\text{thJC}} = f(t_p)$$

parameter:  $D = t_p/T$



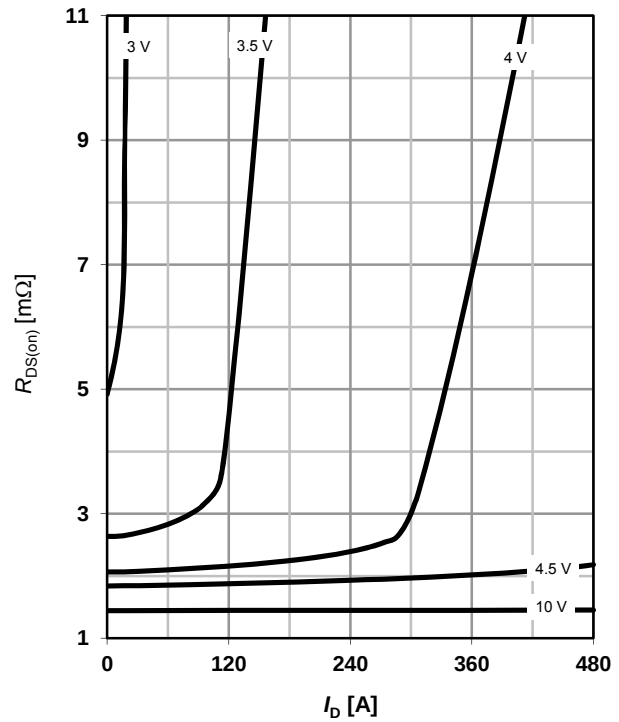
## 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}$ 

parameter:  $V_{GS}$ 


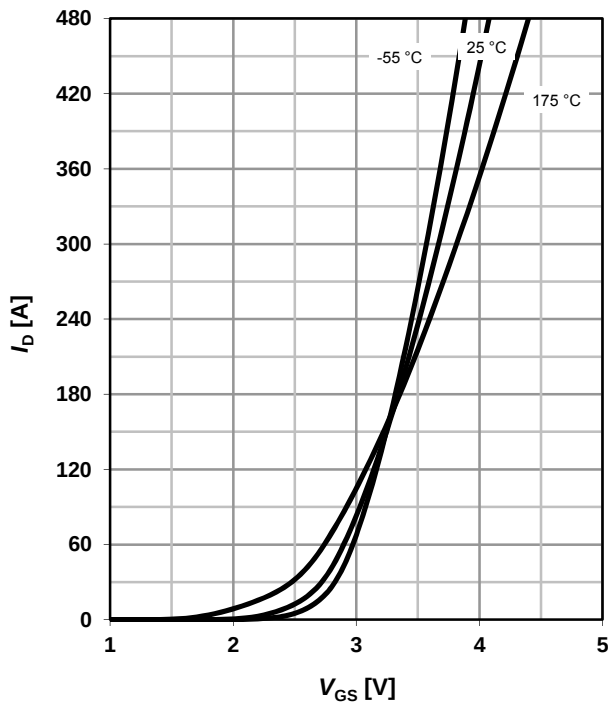
## 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$ 

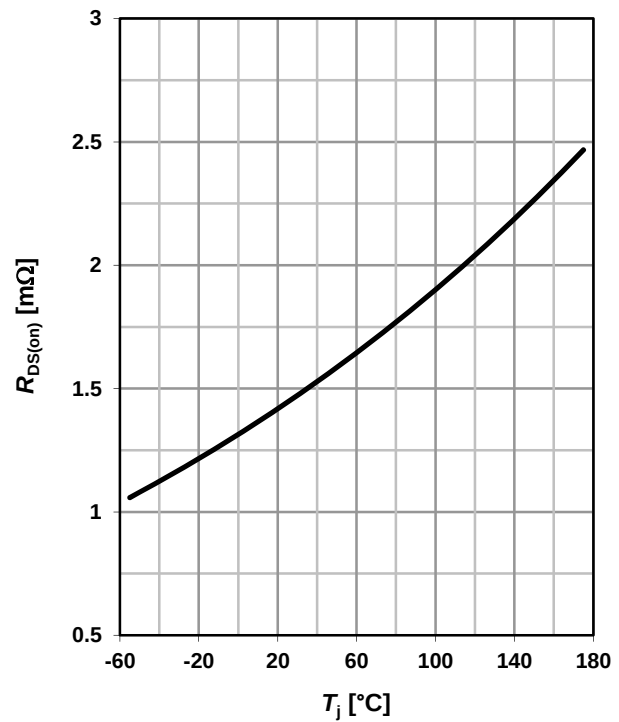
parameter:  $V_{GS}$ 


## 7 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 6\text{ V}$ 

parameter:  $T_j$ 


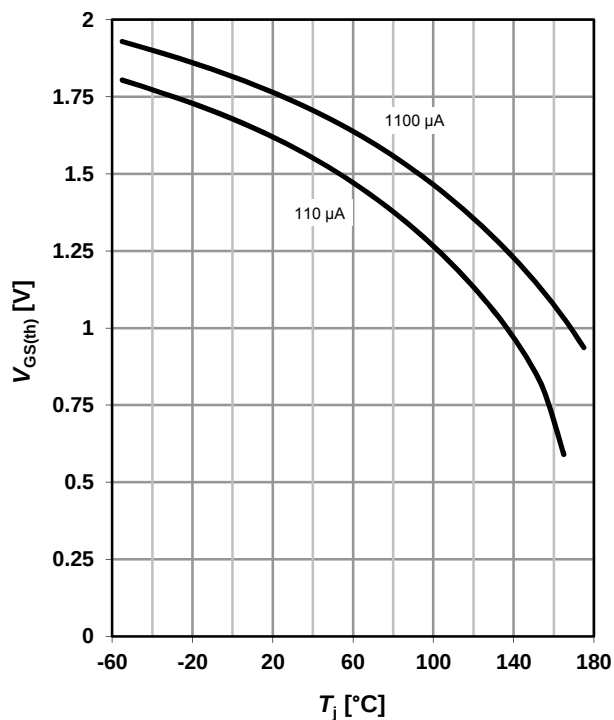
## 8 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j); I_D = 100\text{ A}; V_{GS} = 10\text{ V}$ 


## 9 Typ. gate threshold voltage

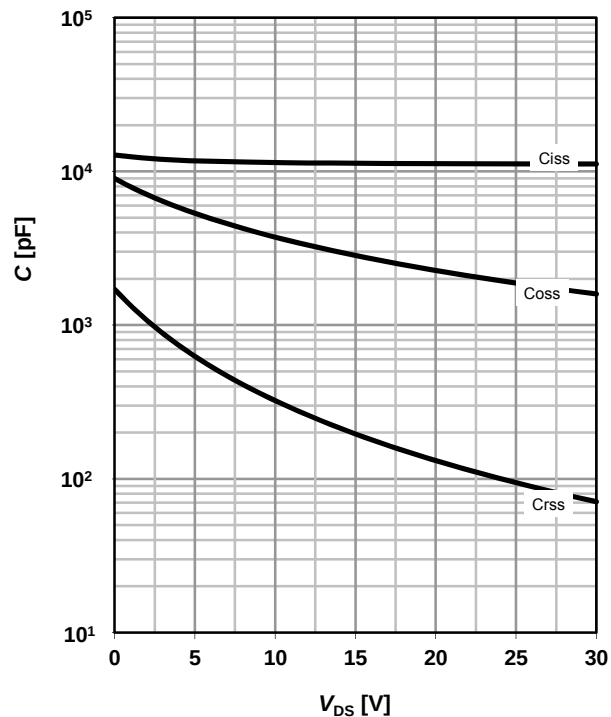
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

parameter:  $I_D$



## 10 Typ. capacitances

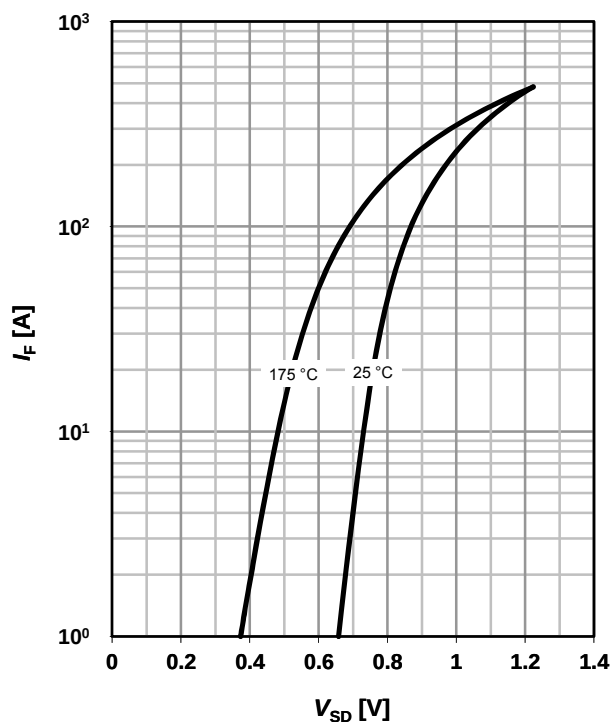
$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$



## 11 Typical forward diode characteristics

$$I_F = f(V_{SD})$$

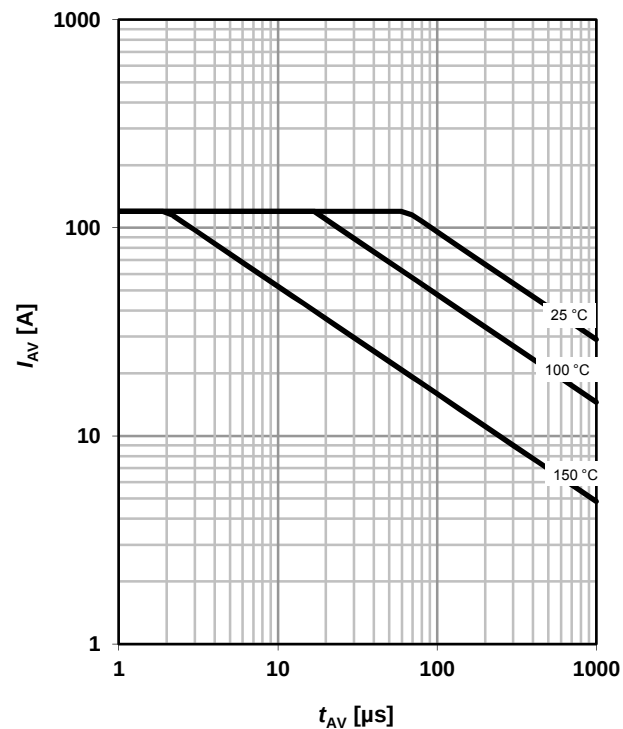
parameter:  $T_j$



## 12 Avalanche characteristics

$$I_{AS} = f(t_{AV})$$

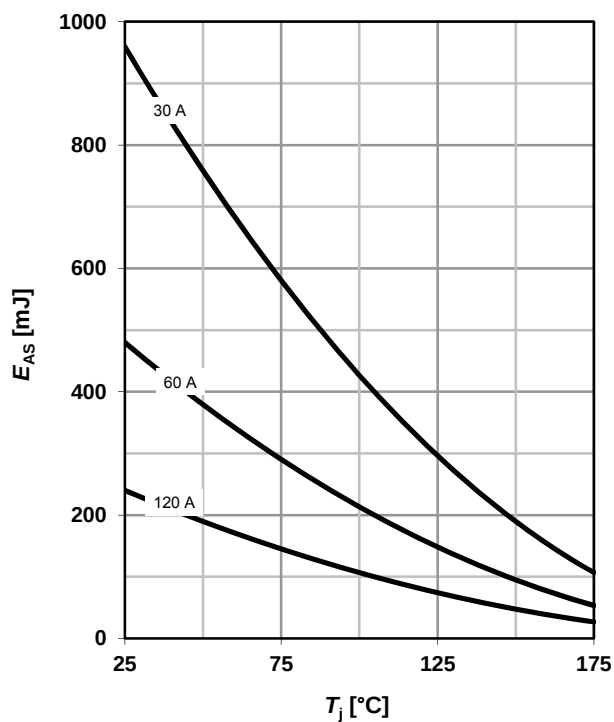
parameter:  $T_{j(start)}$



### 13 Avalanche energy

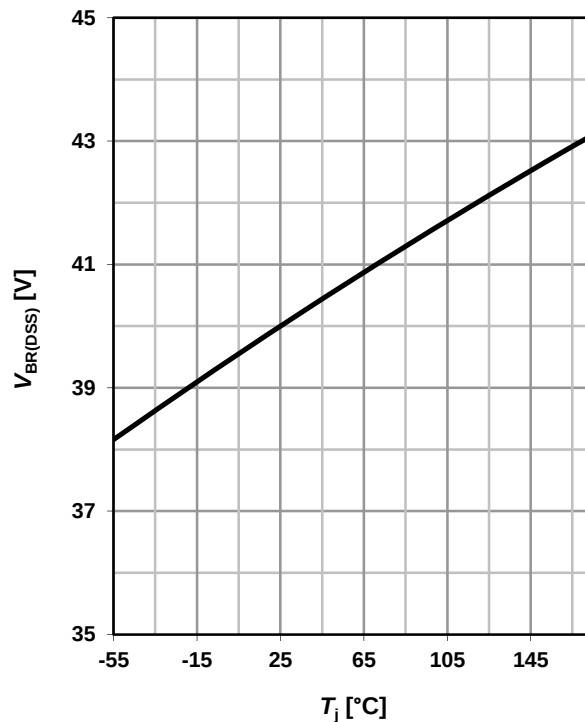
$$E_{AS} = f(T_j)$$

parameter:  $I_D$



### 14 Drain-source breakdown voltage

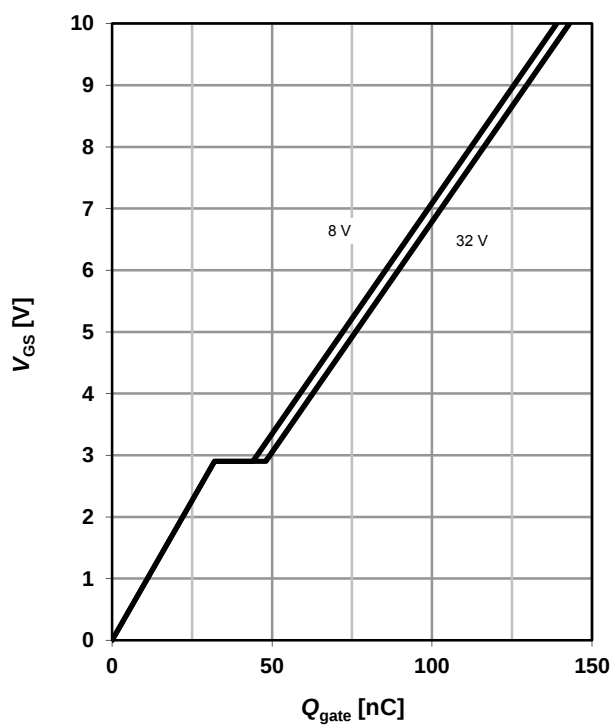
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



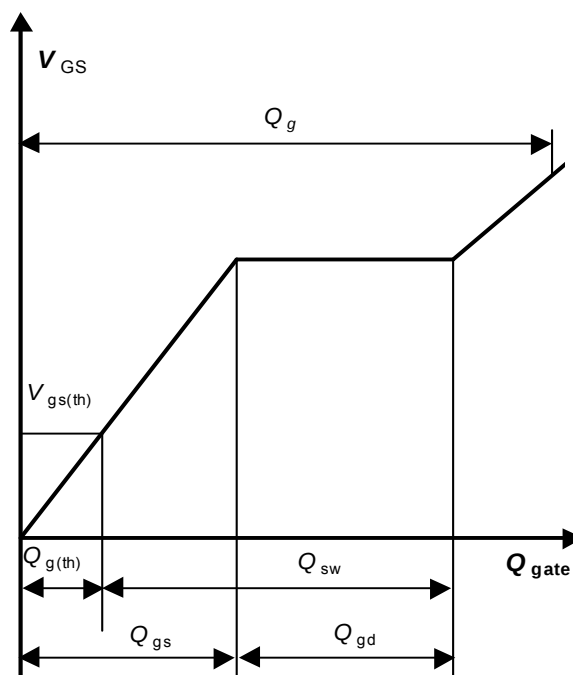
### 15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 120 \text{ A pulsed}$$

parameter:  $V_{DD}$



### 16 Gate charge waveforms



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## Revision History

| Version      | Date       | Changes          |
|--------------|------------|------------------|
| Revision 1.0 | 03.06.2013 | Final Data Sheet |